



N 沟道增强型场效应晶体管

N-CHANNEL MOSFET

FHP50N8F12LA /FHU50N8F12LA/FHD50N8F12LA

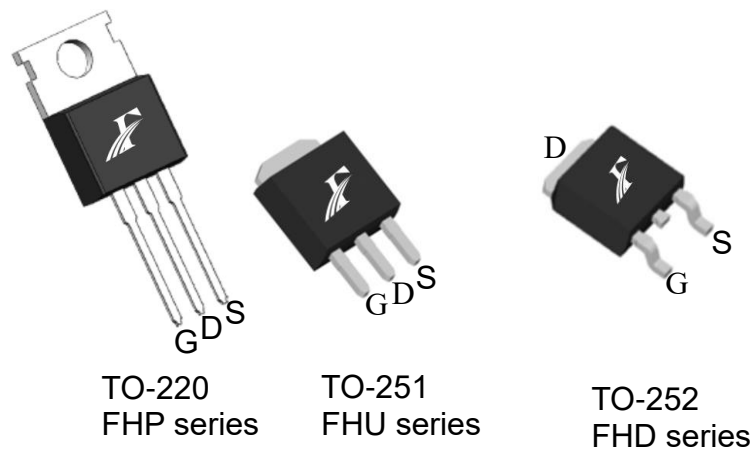
主要参数 MAIN CHARACTERISTICS

ID	50A
VDSS	80 V
Rdson-typ (@Vgs=10V)	14.7mΩ
Rdson-typ (@Vgs=4.5V)	20.7mΩ
Qg-typ	60nC

用途 APPLICATIONS

开关和高频电路	Hard switched and High frequency circuits
开关电源应用	Power switching application

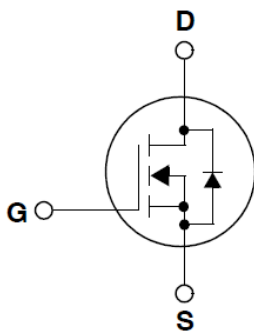
封装形式 Package



产品特性 FEATURES

低栅极电荷	Low gate charge
低 Crss (典型值 2.6pF)	Low Crss (typical 2.6pF)
开关速度快	Fast switching
100%经过雪崩测试	100% avalanche tested
100%经过热阻测试	100% DVDS tested
100%经过 Rg 测试	100% Rg tested
高抗 dv/dt 能力	Improved dv/dt capability
RoHS 产品	RoHS product
SGT 工艺	SGT process

等效电路 Equivalent Circuit



绝对最大额定值 ABSOLUTE RATINGS (Tc25℃)

项目 Parameter	符号 Symbol	数值 Value		单位 Unit
		FHP50N8F12LA	FHU/D50N8F12LA	
最高漏极-源极直流电压 Drain-Source Voltage	V _{DS}	80		V
连续漏极电流* Drain Current -continuous *	I _D (T _C =25℃)	50		A
	I _D (T _C =100℃)	38		A
最大脉冲漏极电流 (注 1) Drain Current – pulse (note 1)	I _{DM}	200		A
最高栅源电压 Gate-Source Voltage	V _{GS}	±20		V
单脉冲雪崩能量 (注 2) Single Pulsed Avalanche Energy (note 2)	E _{AS}	32		mJ
雪崩电流 (注 1) Avalanche Current (note 1)	I _{AS}	8		A
重复雪崩能量 (注 1) Repetitive Avalanche Current (note 1)	E _{AR}	6		mJ
二极管反向恢复最大电压变化速率 (注 3) Peak Diode Recovery dv/dt (note 3)	dv/dt	5.0		V/ns
耗散功率 Power Dissipation	P _D (T _C =25℃)	143	66	W
	-Derate above 25℃	0.95	0.53	W/℃
最高结温及存储温度 Operating and Storage Temperature Range	T _J , T _{STG}	175,-55~+150		℃
引线最高焊接温度 Maximum Lead Temperature for Soldering Purposes	T _L	300		℃

*漏极电流由最高结温限制

*Drain current limited by maximum junction temperature

电特性 ELECTRICAL CHARACTERISTICS

项目 Parameter	符号 Symbol	测试条件 Tests conditions	最小 Min	典型 Typ	最大 Max	单位 Units
关态特性 Off –Characteristics						
漏－源击穿电压 Drain-Source Voltage	BV _{DSS}	I _D =250μA, V _{GS} =0V	80	-	-	V
击穿电压温度特性 Breakdown Voltage Temperature Coefficient	ΔBV _{DSS} /Δ T _J	I _D =250μA, referenced to 25℃	-	0.08	-	V/℃
零栅压下漏极漏电流 Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =80V, V _{GS} =0V, T _C =25℃	-	-	1	μA
		V _{DS} =64V, T _C =125℃	-	-	100	μA
栅极体漏电流 Gate-body leakage current	I _{GSS} (F/R)	V _{DS} =0V, V _{GS} =±20V	-	-	±100	nA
通态特性 On-Characteristics						
阈值电压 Gate Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D =250μA	1	1.8	2.5	V
静态导通电阻 Static Drain-Source On-Resistance	R _{DS(ON)}	V _{GS} =10V , I _D =20A	-	14.7	17	mΩ
		V _{GS} =4.5V , I _D =20A		20.7	29	mΩ
正向跨导 Forward Transconductance	g _{fs}	V _{DS} = 10V, I _D =15 A (note 4)	-	17.4	-	S
动态特性 Dynamic Characteristics						
栅电阻 Gate Resistance	R _g	f=1.0MHz, V _{DS} OPEN	-	1.1	-	Ω
输入电容 Input capacitance	C _{iss}	V _{DS} =25V, V _{GS} =0V, f=1.0MHz	-	1230	-	pF
输出电容 Output capacitance	C _{oss}		-	90	-	
反向传输电容 Reverse transfer capacitance	C _{rss}		-	2.6	-	
开关特性 Switching Characteristics						
延迟时间 Turn-On delay time	t _{d(on)}	V _{DS} =30V, I _D =20A, R _G =3Ω V _{GS} =10V (note 4, 5)	-	12	-	ns
上升时间 Turn-On rise time	t _r		-	9	-	ns
延迟时间 Turn-Off delay time	t _{d(off)}		-	20	-	ns
下降时间 Turn-Off Fall time	t _f		-	18	-	ns
栅极电荷总量 Total Gate Charge	Q _g	V _{DS} =40V , I _D =20A, V _{GS} =10V (note 4, 5)	-	60	-	nC
栅－源电荷 Gate-Source charge	Q _{gs}		-	12	-	nC
栅－漏电荷 Gate-Drain charge	Q _{gd}		-	35	-	nC
漏－源二极管特性及最大额定值 Drain-Source Diode Characteristics and Maximum Ratings						
正向最大连续电流 Maximum Continuous Drain-Source Diode Forward Current	I _S		-	-	50	A
正向最大脉冲电流 Maximum Pulsed Drain-Source Diode Forward Current	I _{SM}		-	-	200	A
正向压降 Drain-Source Diode Forward Voltage	V _{SD}	V _{GS} =0V, I _S =20A	-	-	1.2	V
反向恢复时间 Reverse recovery time	t _{rr}	V _{GS} =0V, I _S =20A, dI _F /dt=100A/μs (note 4)	-	410	-	ns
反向恢复电荷 Reverse recovery charge	Q _{rr}		-	2320	-	nC

20A

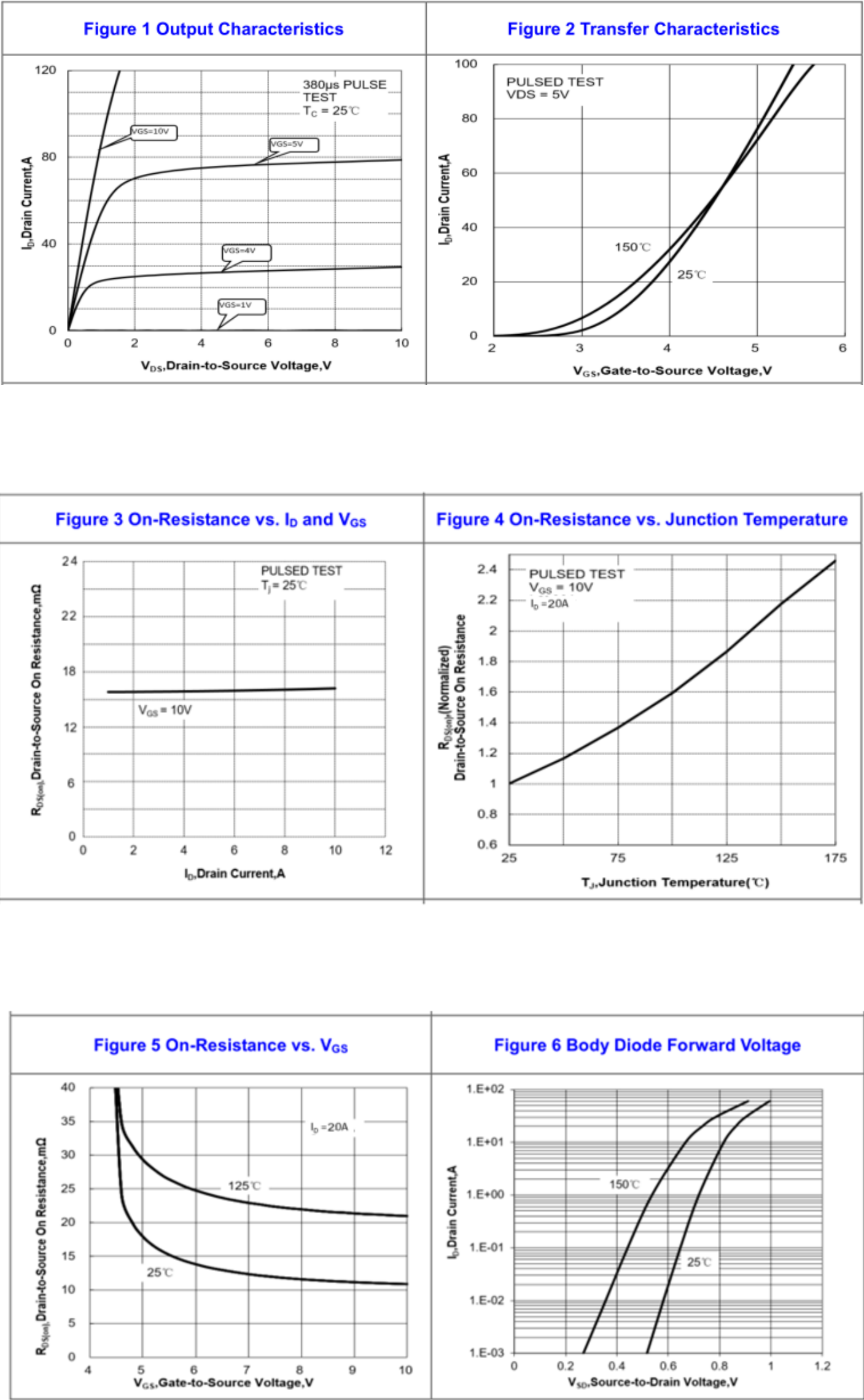
热特性 THERMAL CHARACTERISTIC

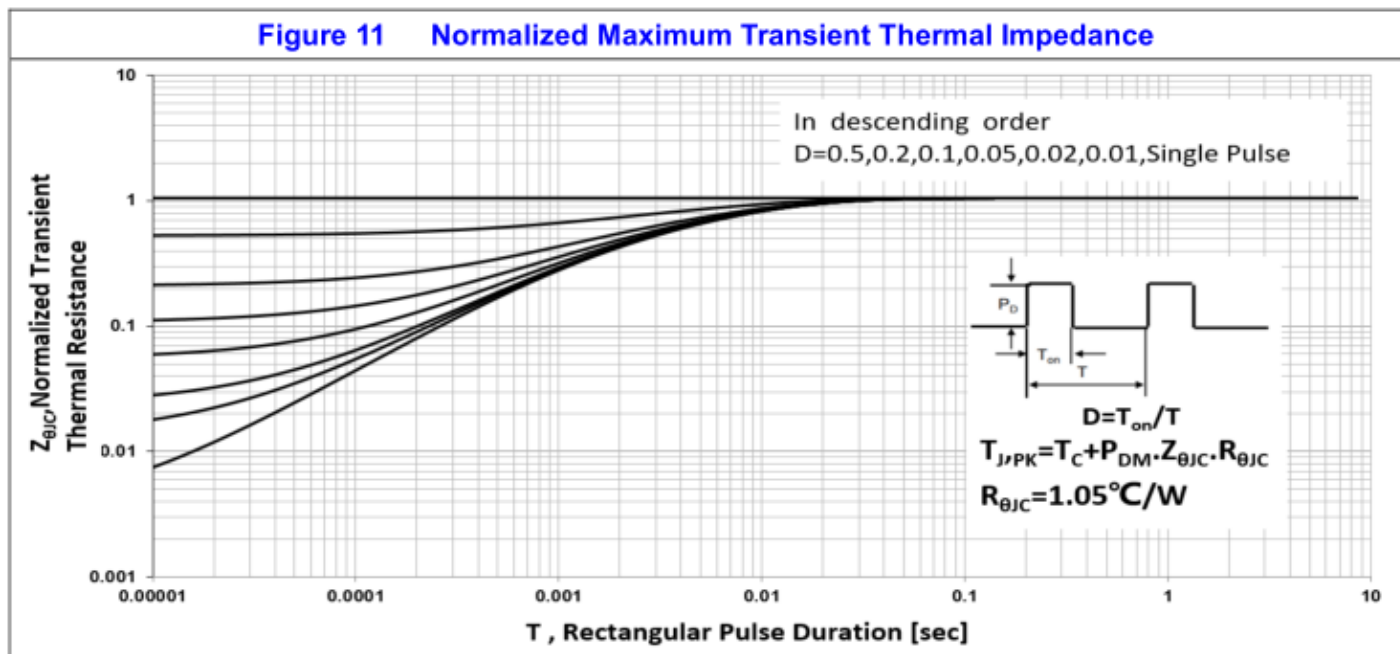
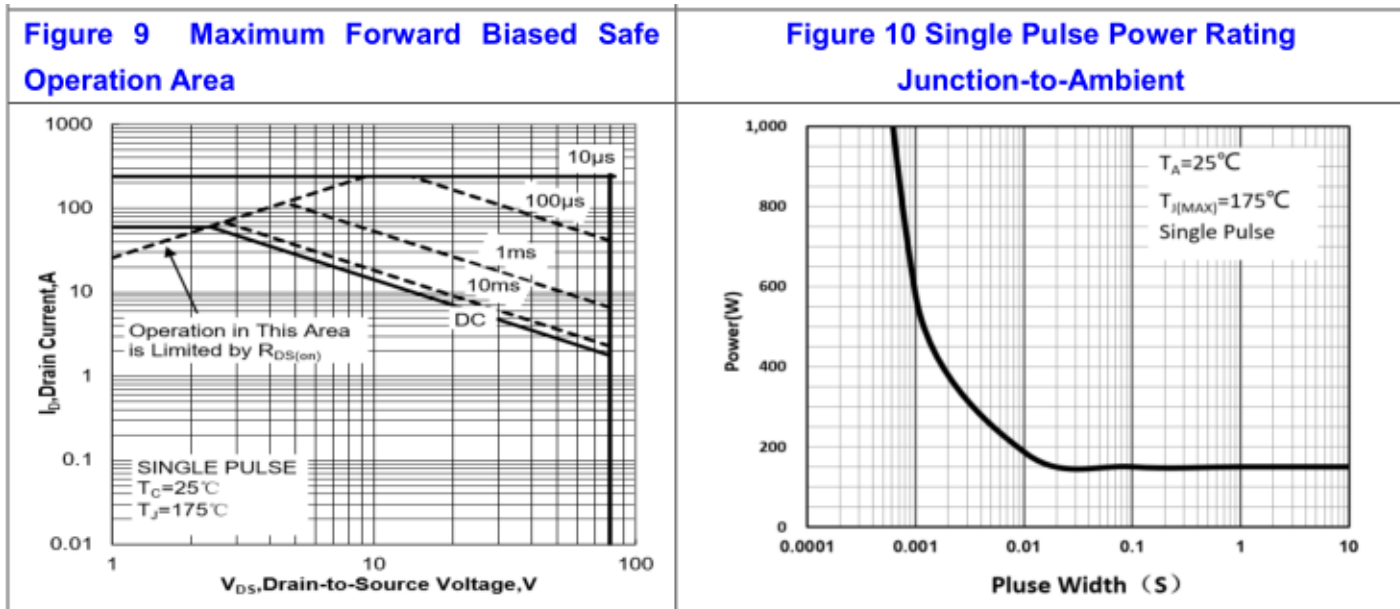
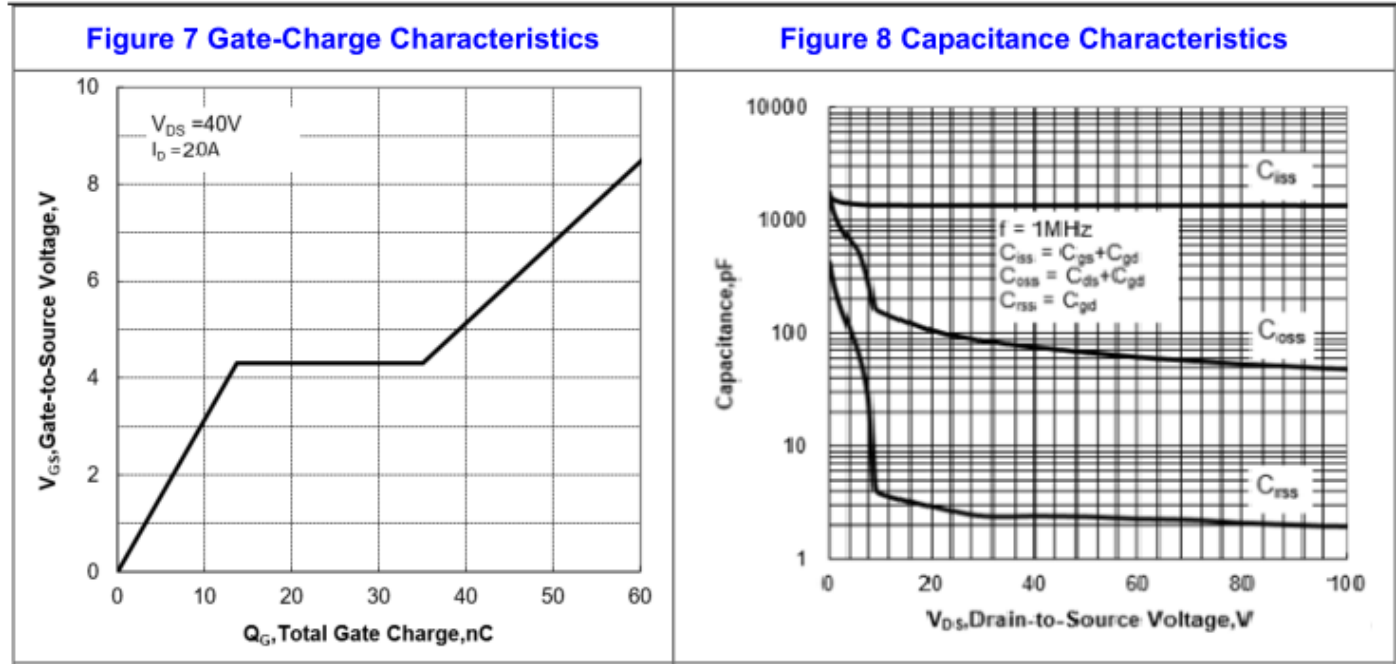
项目 Parameter	符号 Symbol	FHP50N8F12LA	FHU/D50N8F12LA	单位 Unit
结到管壳的热阻 Thermal Resistance, Junction to Case	Rth(j-c)	1.05	1.89	℃/W
结到环境的热阻 Thermal Resistance, Junction to Ambient	Rth(j-A)	62.5	62.5	℃/W

- 注释：
- 1: 脉冲宽度由最高结温限制
 - 2: L=1mH, IAS=8A, VDD=50V, RG=25 Ω,起始结温 TJ=25℃
 - 3: ISD ≤50 A,di/dt ≤100A/μs,VDD≤BVdss,起始结温 TJ=25℃
 - 4: 脉冲测试：脉冲宽度 ≤300μs,占空比≤2%
 - 5: 基本与工作温度无关

- Notes:
- 1: Pulse width limited by maximum junction temperature
 - 2: L=1mH, IAS=8A, VDD=50V, RG=25 Ω,Starting TJ=25℃
 - 3: ISD ≤50 A,di/dt ≤100A/μs,VDD≤BVdss, Starting TJ=25℃
 - 4: Pulse Test: Pulse Width ≤300μs,Duty Cycle≤2%
 - 5: Essentially independent of operating temperature

特性曲线 Typical Characteristics





Test Circuit & Waveform

Figure 12 Gate Charge Test Circuit

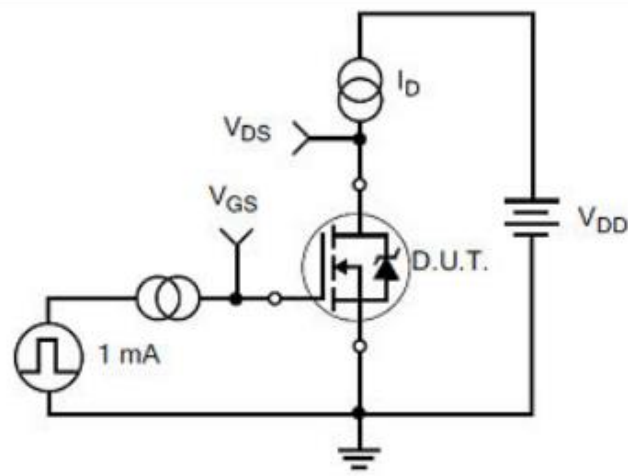


Figure 13 Gate Charge Waveforms

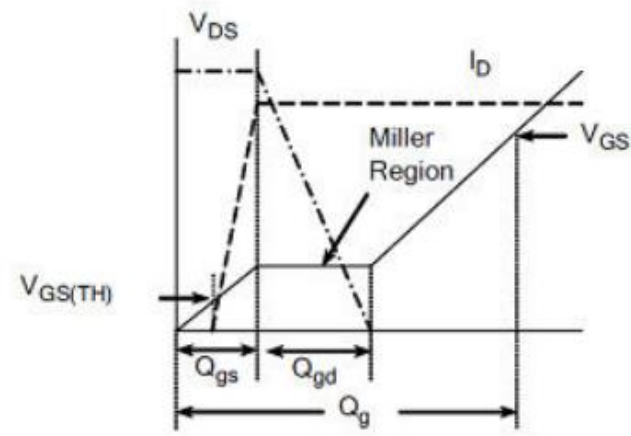


Figure 14 Resistive Switching Test Circuit

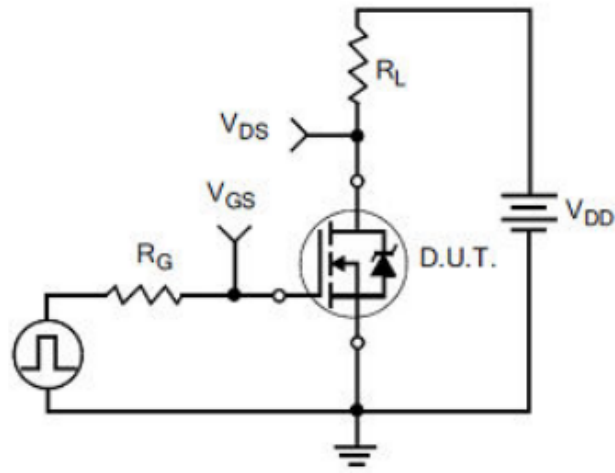


Figure 15 Resistive Switching Waveforms

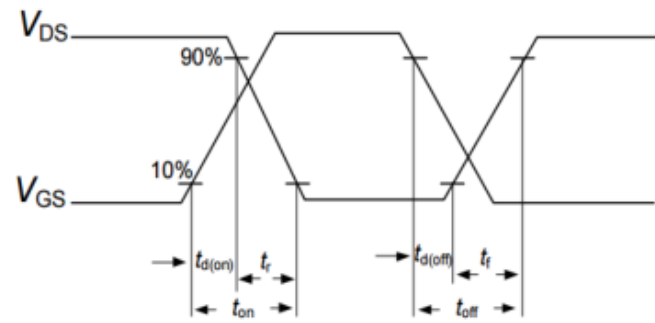


Figure 16 Diode Reverse Recovery Test Circuit

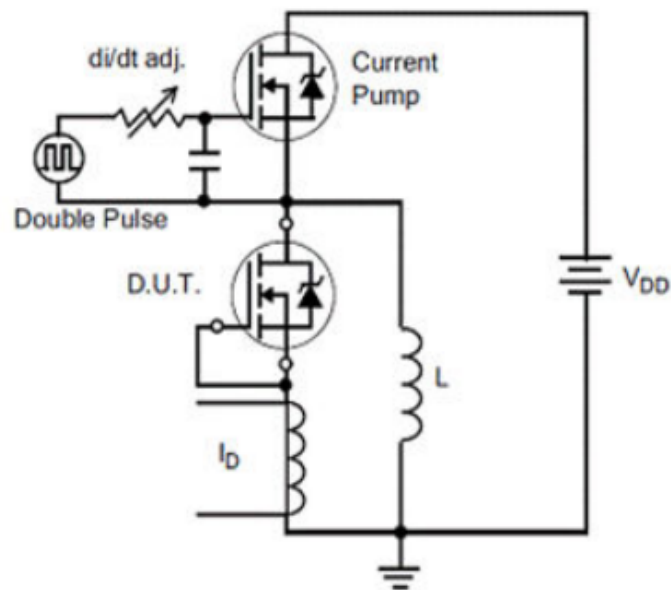


Figure 17 Diode Reverse Recovery Waveform

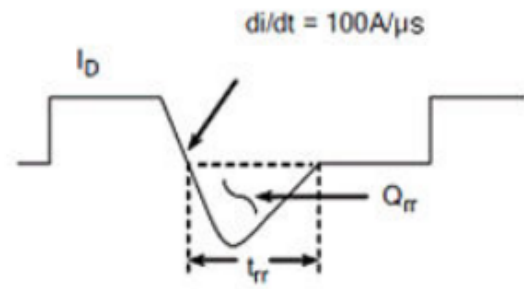


Figure 18 Unclamped Inductive Switching Test Circuit

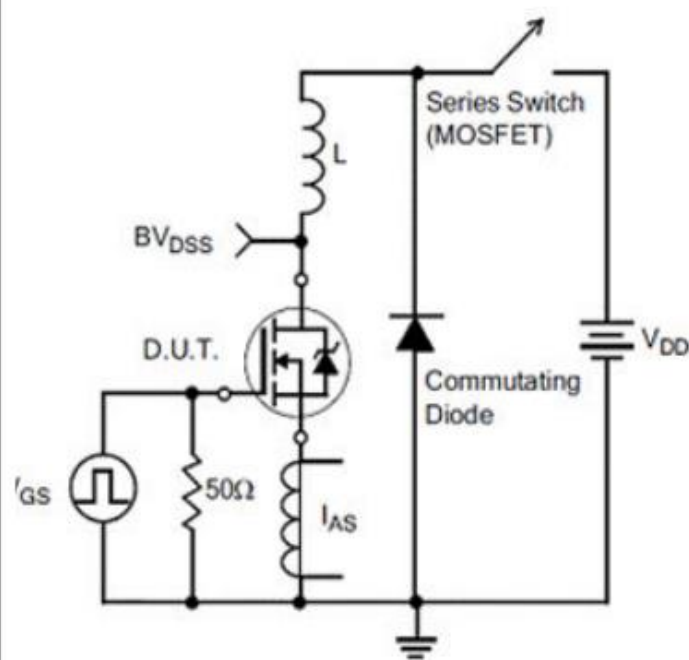
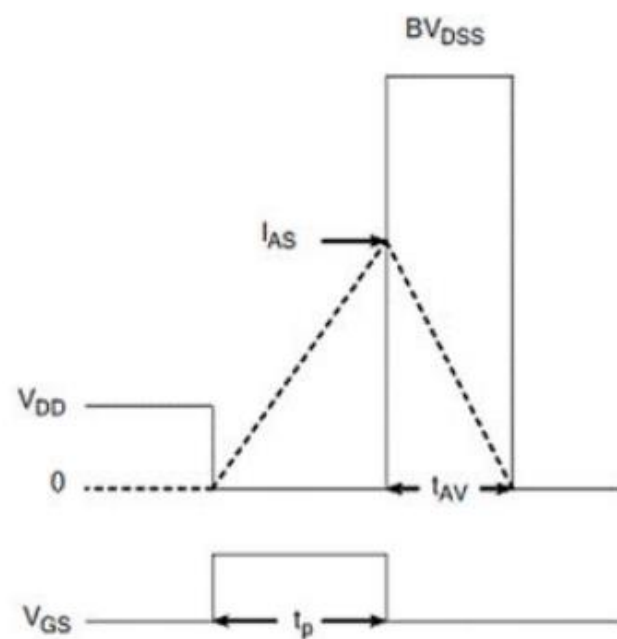
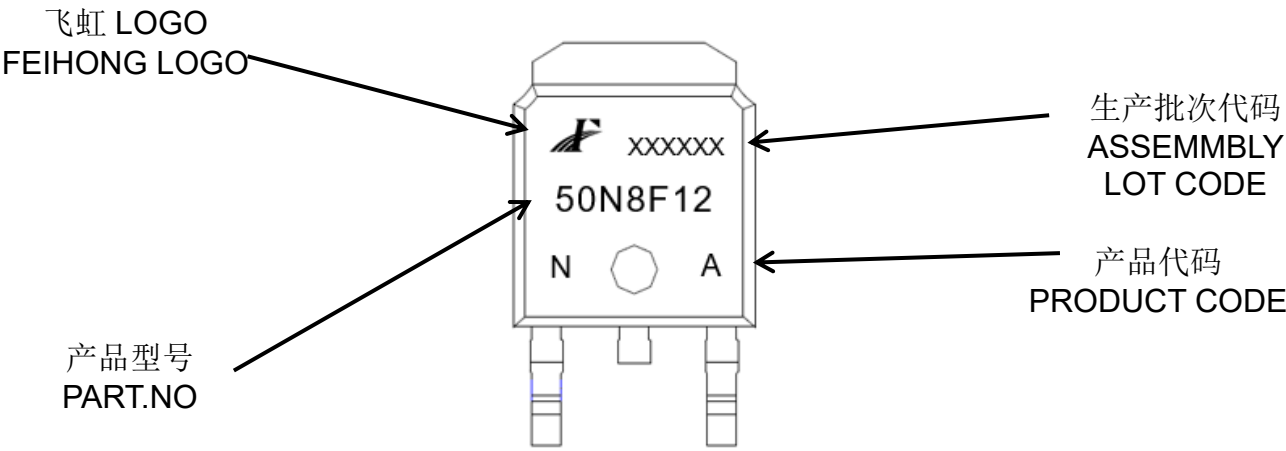
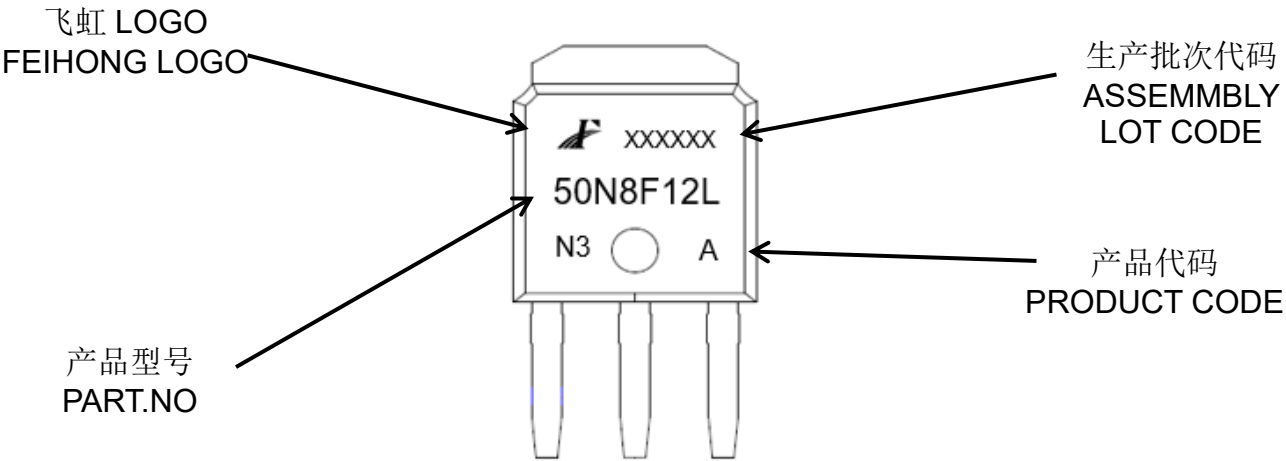
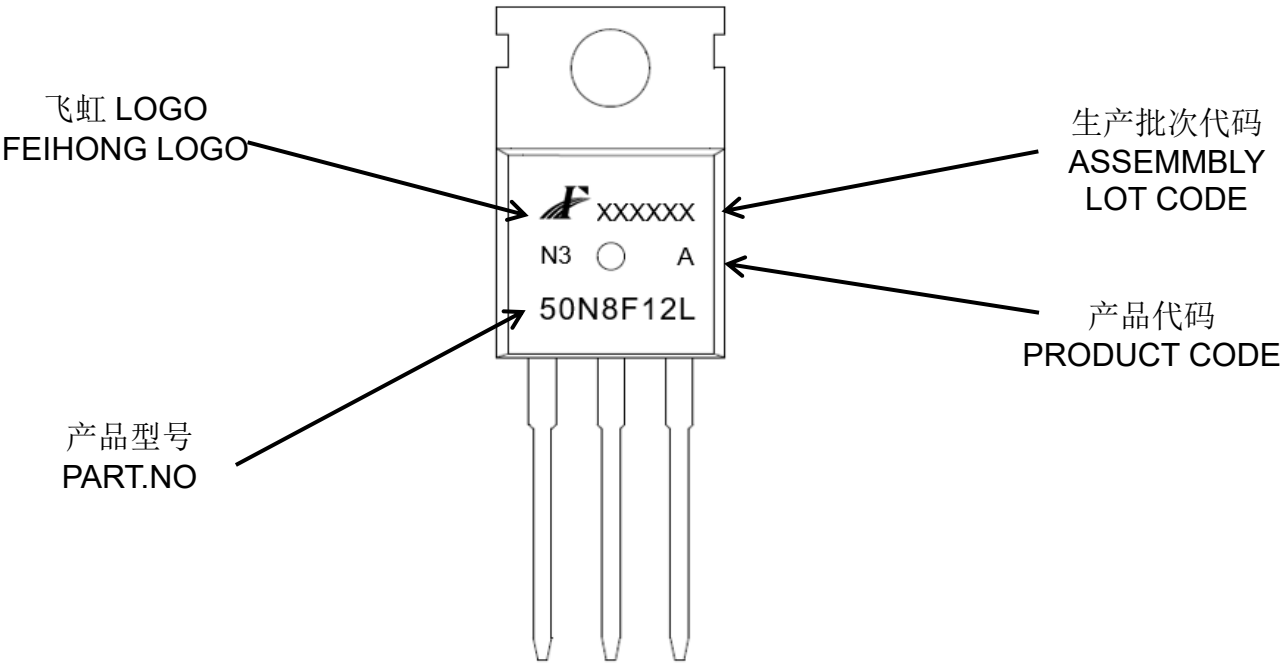


Figure 19 Unclamped Inductive Switching Waveform



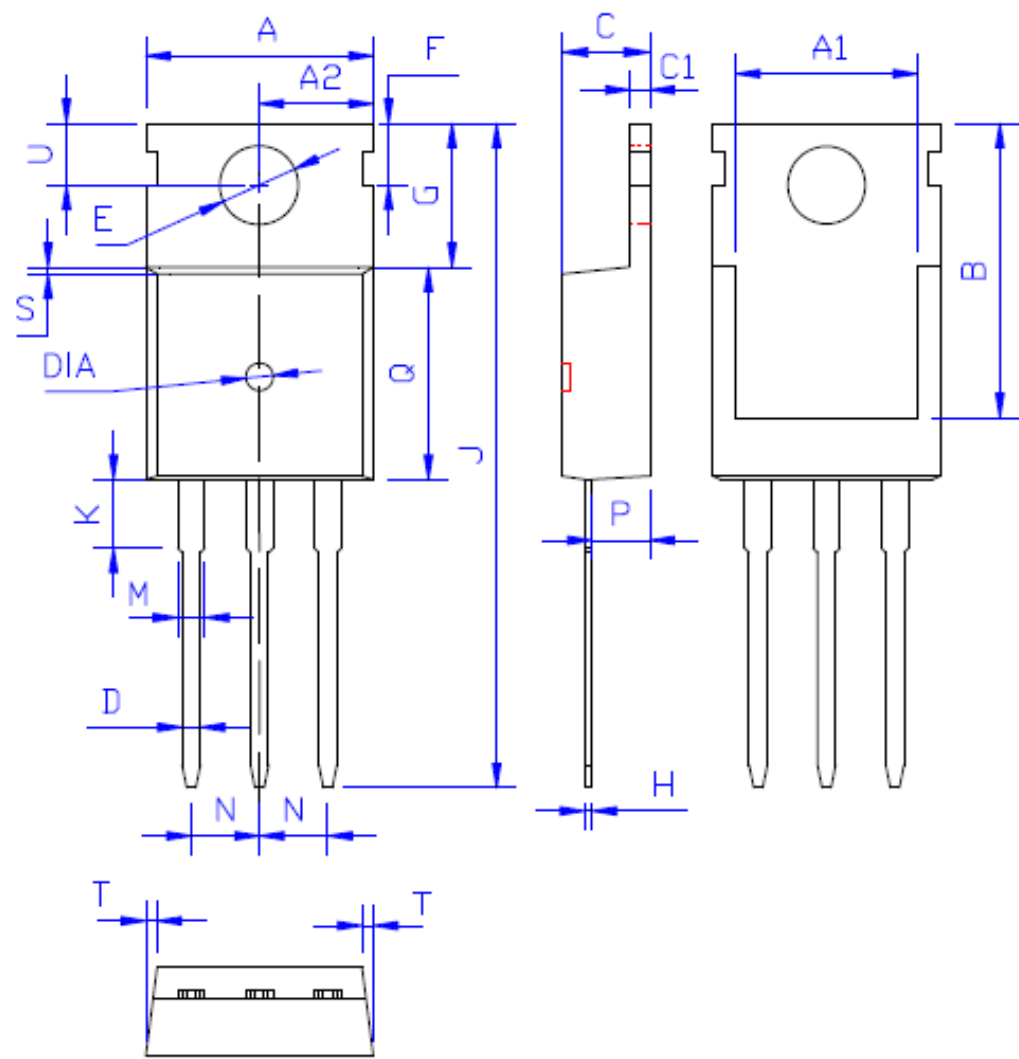
印记 Marking:



外形尺寸:

Package Dimension:

TO-220



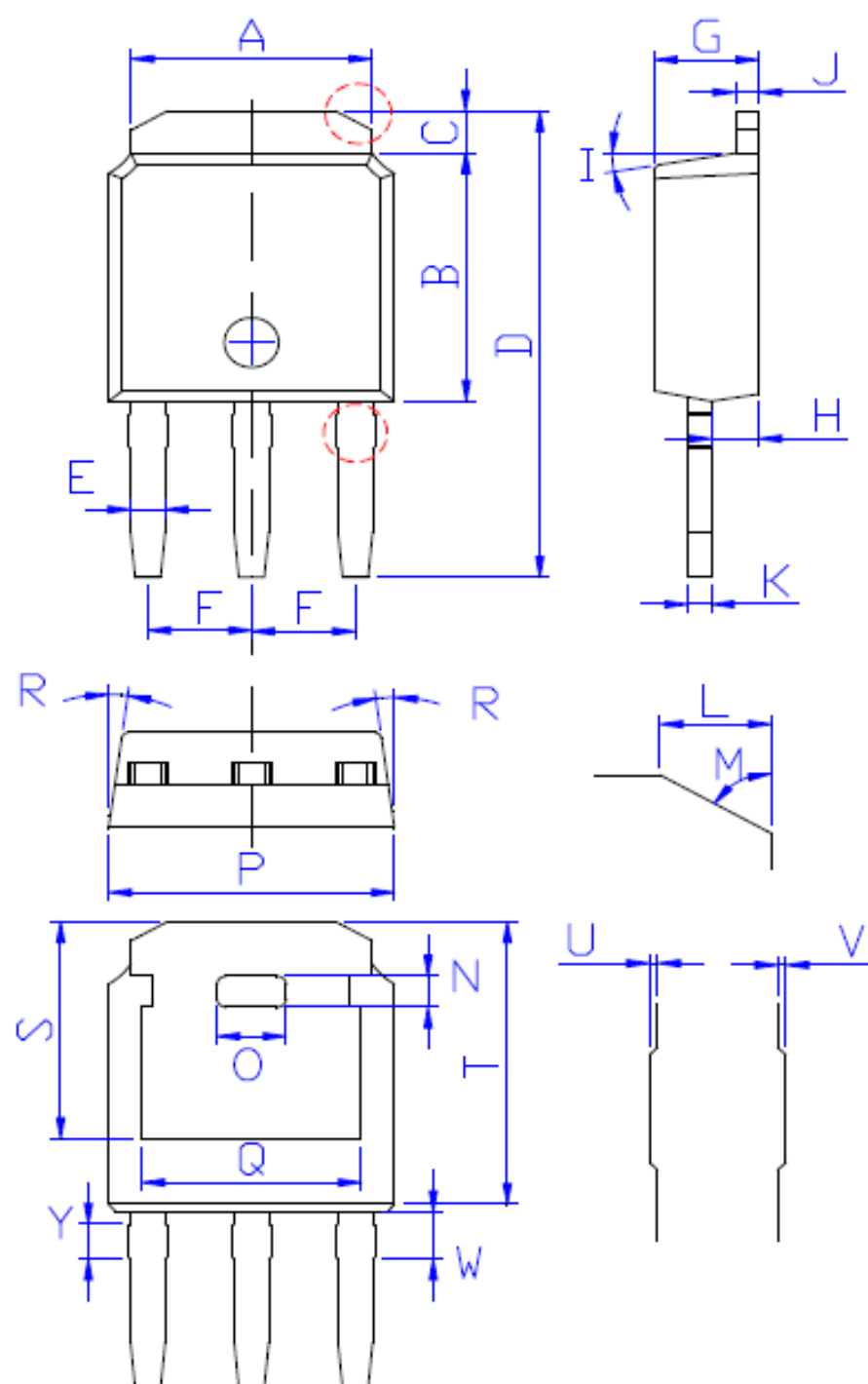
DIM	MILLIMETERS
A	10.00±0.30
A1	8.00±0.30
A2	5.00±0.30
B	13.20±0.40
C	4.50±0.20
C1	1.30±0.20
D	0.80±0.20
E	3.60±0.20
F	3.00±0.30
G	6.60±0.40
H	0.50±0.20
J	28.88±0.50
K	3.00±0.30
M	1.30±0.30
N	Typical 2.54
P	2.40±0.40
Q	9.20±0.40
S	0.25±0.15
T	0.25±0.15
U	2.80±0.30
DIA	宽 1.50±0.10 深 0.50 MAX

(Unit: mm)

外形尺寸:

Package Dimension:

TO-251



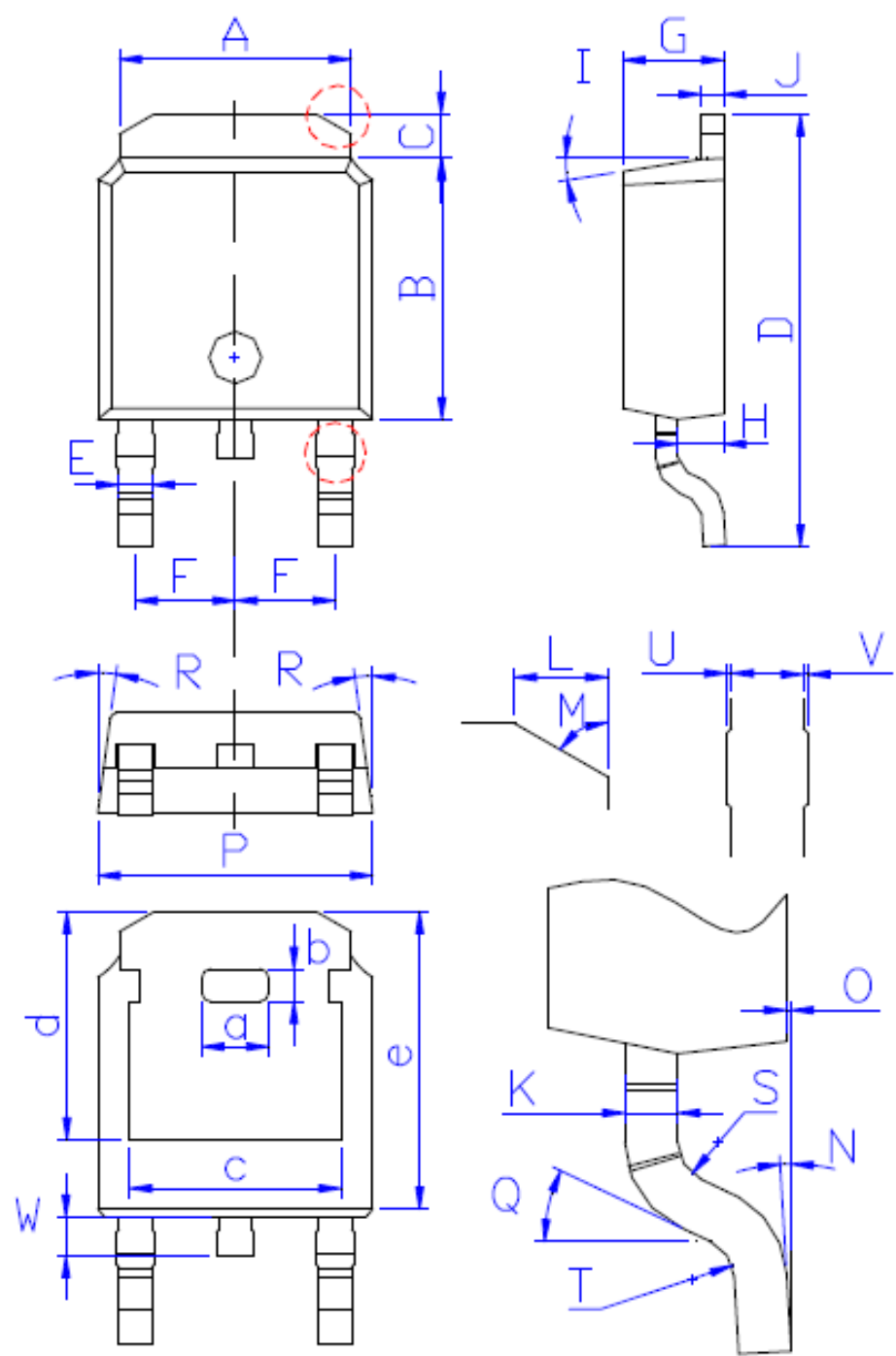
DIM	MILLIMETERS
A	5.34±0.30
B	6.00±0.30
C	1.05±0.30
D	11.31±0.30
E	0.76±0.15
F	2.28±0.15
G	2.30±0.30
H	1.06±0.30
I	(4-10)°
J	0.51±0.15
K	0.52±0.15
L	0.80±0.30
M	60°
N	0.75±0.30
O	1.80±0.30
P	6.60±0.30
Q	4.85±0.30
R	(4-8.5)°
S	5.30±0.30
T	6.90±0.30
U	0.05±0.05
V	0.05±0.05
W	1.15±0.25
Y	0.85±0.25

(Unit: mm)

外形尺寸:

Package Dimension:

TO-252



DIM	MILLIMETERS
A	5.34±0.30
B	6.00±0.30
C	1.05±0.30
D	9.95±0.30
E	0.76±0.15
F	2.28±0.15
G	2.30±0.30
H	1.06±0.30
I	(4-10)°
J	0.51±0.15
K	0.52±0.15
L	0.80±0.30
M	60°
N	(0-10)°
O	0.05±0.05
P	6.60±0.30
Q	25°
R	(4-8.5)°
S	R0.40
T	R0.40
U	0.05±0.05
V	0.05±0.05
W	0.90±0.30
a	1.80±0.30
b	0.75±0.30
c	4.85±0.30
d	5.30±0.30
e	6.90±0.30

(Units: mm)